Docket No.

250890US2S

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

IN RE APPLICATION OF: Takahiko YOSHIZAWA, et al.

SERIAL NO: New Application

GAU:

FILED:

Herewith

EXAMINER:

FOR:

....

SEMICONDUCTOR DEVICE AND METHOD OF MANUFACTURING THE SAME

INFORMATION DISCLOSURE STATEMENT UNDER 37 CFR 1.97

COMMISSIONER FOR PATENTS ALEXANDRIA, VIRGINIA 22313

SIR:

Applicant(s) wish to disclose the following information.

REFERENCES

- The applicant(s) wish to make of record the references listed on the attached form PTO-1449. Copies of the listed references are attached, where required, as are either statements of relevancy or any readily available English translations of pertinent portions of any non-English language references.
- ☐ A check or credit card payment form is attached in the amount required under 37 CFR §1.17(p).

RELATED CASES

- Attached is a list of applicant's pending application(s) or issued patent(s) which may be related to the present application. A copy of the patent(s), together with a copy of the claims and drawings of the pending application(s) is attached along with PTO 1449.
- ☐ A check or credit card payment form is attached in the amount required under 37 CFR §1.17(p).

CERTIFICATION

- ☐ Each item of information contained in this information disclosure statement was first cited in any communication from a foreign patent office in a counterpart foreign application not more than three months prior to the filing of this statement.
- □ No item of information contained in this information disclosure statement was cited in a communication from a foreign patent office in a counterpart foreign application or, to the knowledge of the undersigned, having made reasonable inquiry, was known to any individual designated in 37 CFR §1.56(c) more than three months prior to the filing of this statement.

DEPOSIT ACCOUNT

Please charge any additional fees for the papers being filed herewith and for which no check or credit card payment is enclosed herewith, or credit any overpayment to deposit account number <u>15-0030</u>. A duplicate copy of this sheet is enclosed.

Respectfully submitted,

OBLON, SPIVAK, McCLELLAND, MAIER & NEUSTADT, P.C.

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C. Irvin McClelland Registration Number 21,124

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Form PTO 1449		U.S. DEPARTMENT (ATTY DOCKET NO.		SERIAL NO.		
(Modified)		PATENT AND TRAD	EMARK OFFICE	250890US2S	New Application			
				APPLICANT				
LIST OF REFERENCES CITED BY APPLICANT				Takahiko YOSHIZAWA, et al.				
				FILING DATE		GROUP		
				Herewith	<u> </u>			
U.S. PATENT DOCUMENTS								
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE	
	AA							
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	AO							
	AP							
	AQ							
	AR							
	AS							
	AT			·				
	AU							
	AV							
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)								
	AW	J. C. LIN, et al. "Via First Dual Damascene Integration of Nanoporous Ultra Low-k Material", PROCEEDINGS OF INTERNATIONAL INTERCONNECT TECHNOLOGY CONFERENCE, 2002, pgs. 48-50						
	AX	T. MOURIER, et al. "Porous Low k Pore Sealing Process Study for 65 nm and Below Technologies", PROCEEDING OF INTERNATIONAL INTERCONNECT TECHNOLOGY CONFERENCE, 2003, pgs. 245-247						
	AY							
	AZ				Additional References sheet(s) attached			
Examiner					Date Considered			
*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.								
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